

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HASEI ET AL.	
		Examiner Yewebdar T. Tadesse	Art Unit 1734	Page 1 of 1

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*	B	US-2003/0232128 A1	12-2003	Furusawa et al.	427/58
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	M	US-			

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**NON-PATENT DOCUMENTS**

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